

MOSFET

OptiMOS[™]5 Power-Transistor, 150 V

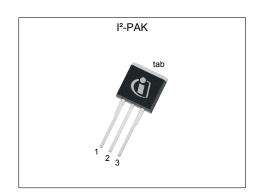
Features

- Excellent gate charge x R_{DS(on)} product (FOM)

- Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}
 Very low reverse recovery charge (Q_{rr)}
 175 °C operating temperature
 Pb-free lead plating; RoHS compliant
 Qualified according to JEDEC¹⁾ for target application
 Ideal for high-frequency switching and synchronous rectification
 Halogen-free according to IEC61249-2-21



Table 1 Rey 1 chombane 1 arameters							
Parameter	Value	Unit					
V _{DS}	150	V					
R _{DS(on),max}	7.6	mΩ					
I_{D}	112	A					
Q _{rr}	96	nC					











Type / Ordering Code	Package	Marking	Related Links
IPI076N15N5	PG-TO262-3	076N15N5	-

OptiMOS[™]5 Power-Transistor, 150 V



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OptiMOS[™]5 Power-Transistor, 150 V . IPI076N15N5



1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 **Maximum ratings**

Dava-marta v	Combal	Values				Nets / Test Ossalition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current	I _D	-	-	112 79	А	T _C =25 °C T _C =100 °C	
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	448	Α	T _C =25 °C	
Avalanche energy, single pulse ²⁾	E AS	-	-	130	mJ	I_D =100 A, R_{GS} =25 Ω	
Gate source voltage	V _{GS}	-20	-	20	V	-	
Power dissipation	P _{tot}	-	-	214	W	T _C =25 °C	
Operating and storage temperature	T _j , T _{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56	

Thermal characteristics 2

Table 3 Thermal characteristics

Davamatav	Cumbal	Values			11:4	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R _{thJC}	-	0.4	0.7	K/W	-	
Thermal resistance, junction - ambient, minimal footprint	R _{thJA}	-	-	62	K/W	-	

3 **Electrical characteristics**

Table 4 **Static characteristics**

Parameter	Cymbol		Values			Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	$V_{(BR)DSS}$	150	-	-	V	V _{GS} =0 V, I _D =1 mA	
Gate threshold voltage	shold voltage $V_{GS(th)}$ 3.0 3.8 4.6 V $V_{DS}=V_{GS}$, $I_D=160~\mu A$		$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 160 \ \mu {\rm A}$				
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μA	V _{DS} =120 V, V _{GS} =0 V, T _j =25 °C V _{DS} =120 V, V _{GS} =0 V, T _j =125 °C	
Gate-source leakage current	I _{GSS}	-	1	100	nA	V _{GS} =20 V, V _{DS} =0 V	
Drain-source on-state resistance	R _{DS(on)}	-	5.9 6.4	7.6 8.4	mΩ	V _{GS} =10 V, I _D =56 A V _{GS} =8 V, I _D =28 A	
Gate resistance ³⁾	R _G	-	1.1	1.7	Ω	-	
Transconductance	g fs	45	90	-	S	$ V_{DS} > 2 I_D R_{DS(on)max}, I_D = 56 \text{ A}$	

See Diagram 3
 See Diagram 13
 Defined by design. Not subject to production test.

OptiMOS[™]5 Power-Transistor, 150 V IPI076N15N5



Table 5 Dynamic characteristics

Parameter.	Oala al		Values			Nata (Tant Canadition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance ¹⁾	Ciss	-	3600	4700	pF	V _{GS} =0 V, V _{DS} =75 V, <i>f</i> =1 MHz	
Output capacitance ¹⁾	Coss	-	900	1200	pF	V _{GS} =0 V, V _{DS} =75 V, f=1 MHz	
Reverse transfer capacitance ¹⁾	Crss	-	21	37	pF	V _{GS} =0 V, V _{DS} =75 V, f=1 MHz	
Turn-on delay time	$t_{\sf d(on)}$	-	14	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =56 A, $R_{\rm G,ext}$ =1.6 Ω	
Rise time	t _r	-	4	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =56 A, $R_{\rm G,ext}$ =1.6 Ω	
Turn-off delay time	$t_{ m d(off)}$	-	20	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =56 A, $R_{\rm G,ext}$ =1.6 Ω	
Fall time	t _f	-	4	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =56 A, $R_{\rm G,ext}$ =1.6 Ω	

Table 6 Gate charge characteristics²⁾

Developmentary	Cumbal	Values			11	Nata (Tast Canalities	
Parameter	Symbol		Тур.	Max.	Unit	Note / Test Condition	
Gate to source charge	Q _{gs}	-	21	-	nC	$V_{\rm DD}$ =75 V, $I_{\rm D}$ =56 A, $V_{\rm GS}$ =0 to 10 V	
Gate to drain charge ¹⁾	Q _{gd}	-	10	15	nC	$V_{\rm DD}$ =75 V, $I_{\rm D}$ =56 A, $V_{\rm GS}$ =0 to 10 V	
Switching charge	Q _{sw}	-	17	-	nC	$V_{\rm DD}$ =75 V, $I_{\rm D}$ =56 A, $V_{\rm GS}$ =0 to 10 V	
Gate charge total ¹⁾	Qg	-	49	61	nC	$V_{\rm DD}$ =75 V, $I_{\rm D}$ =56 A, $V_{\rm GS}$ =0 to 10 V	
Gate plateau voltage	V _{plateau}	-	5.7	-	V	$V_{\rm DD}$ =75 V, $I_{\rm D}$ =56 A, $V_{\rm GS}$ =0 to 10 V	
Output charge ¹⁾	Qoss	-	136	181	nC	V _{DD} =75 V, V _{GS} =0 V	

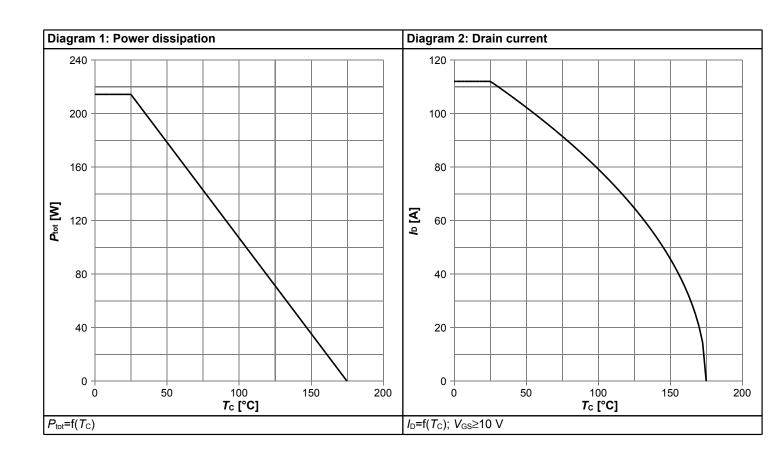
Table 7 Reverse diode

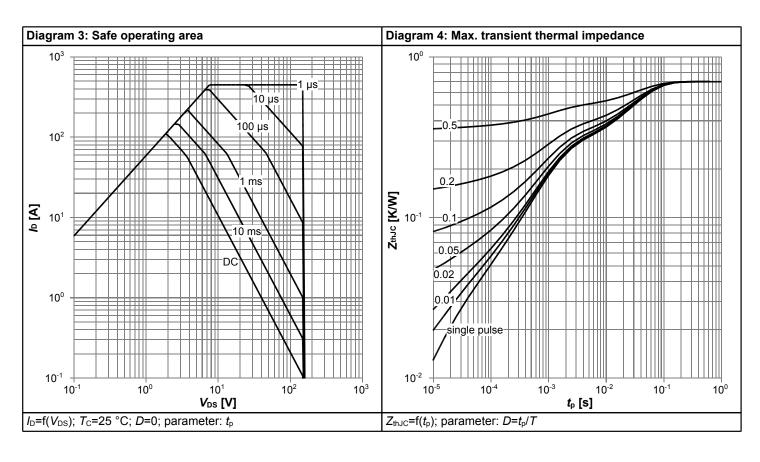
Doromotor	Cumbal	Values			l lmi4	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode continous forward current	Is	-	-	112	Α	T _C =25 °C	
Diode pulse current	I _{S,pulse}	-	-	448	Α	<i>T</i> _C =25 °C	
Diode forward voltage	V _{SD}	-	0.89	1.1	V	V _{GS} =0 V, I _F =56 A, T _j =25 °C	
Reverse recovery time ¹⁾	<i>t</i> _{rr}	-	69	138	ns	V _R =75 V, I _F =56 A, di _F /dt=100 A/μs	
Reverse recovery charge ¹⁾	Qrr	-	96	192	nC	V _R =75 V, I _F =56 A, di _F /dt=100 A/μs	

 $^{^{1)}}$ Defined by design. Not subject to production test. $^{2)}$ See "Gate charge waveforms" for parameter definition

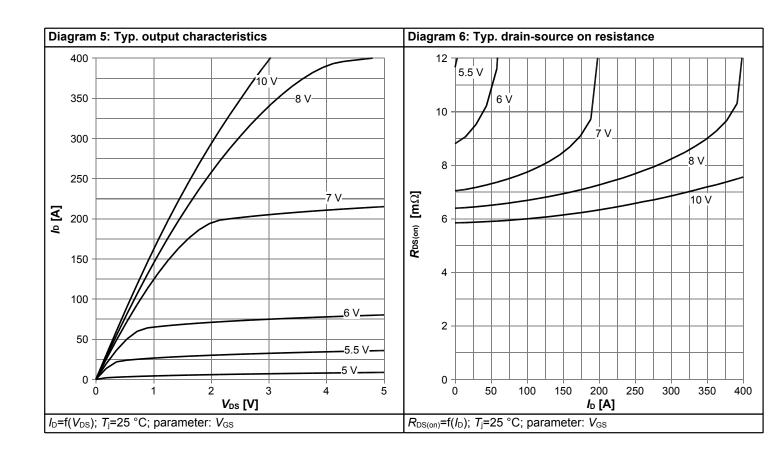


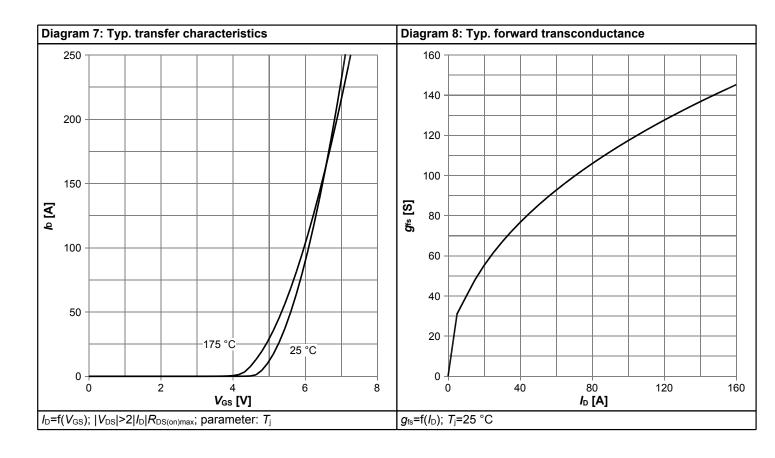
4 Electrical characteristics diagrams



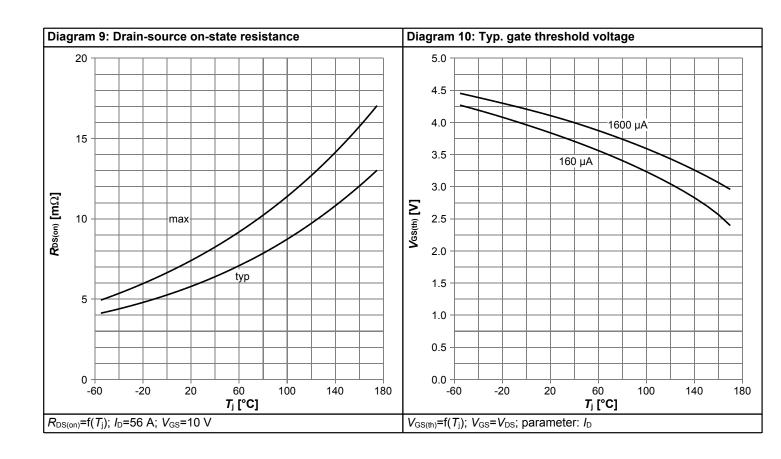


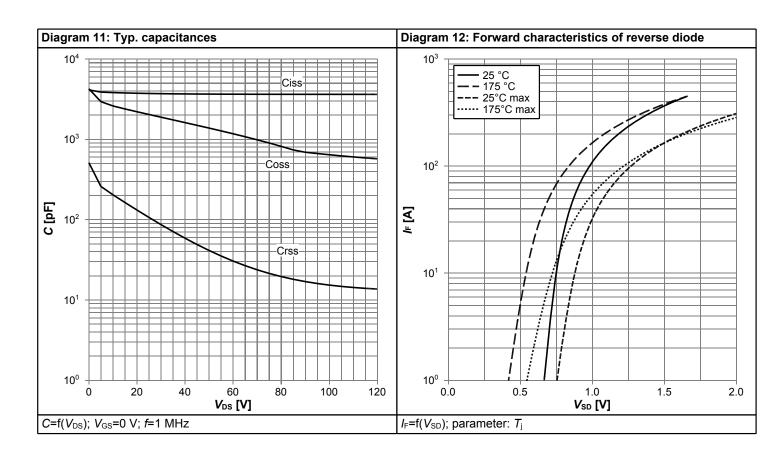




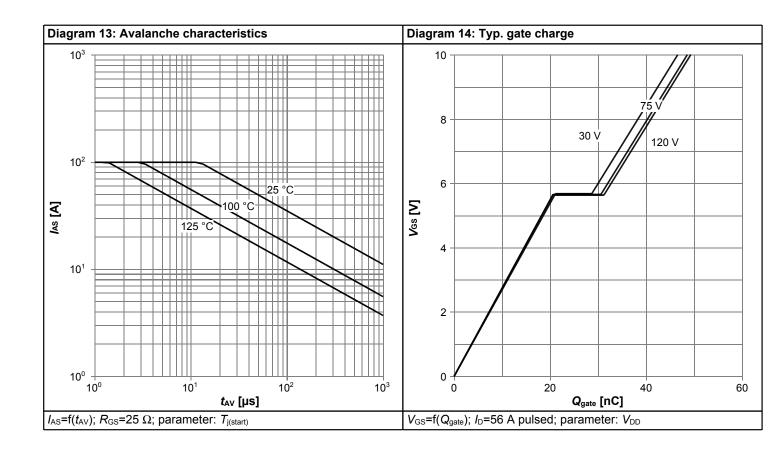


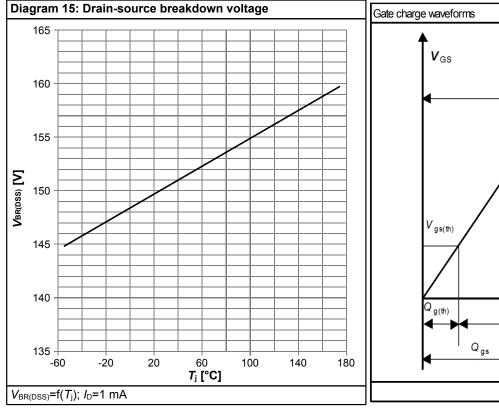


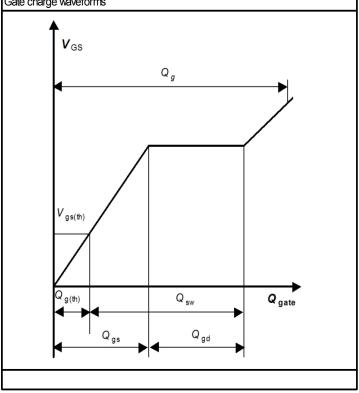






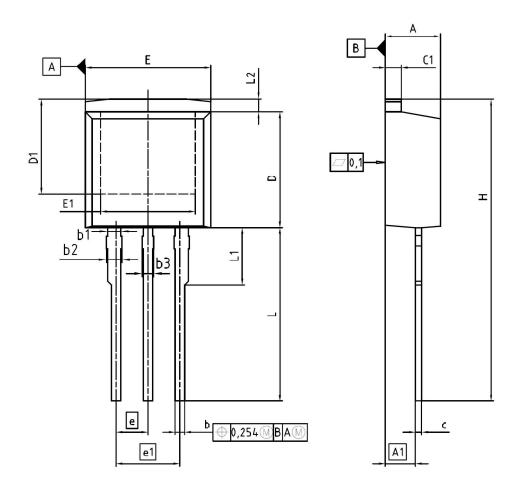








5 Package Outlines



DIM	MILLIM	ETERS	INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	4.300	4.572	0.169	0.180		
A1	2.150	2.718	0.085	0.107		
b	0.650	0.864	0.026	0.034		
b1	0.950	1.093	0.037	0.043		
b2	0.950	1.400	0.037	0.055		
b3	0.650	1.118	0.026	0.044		
С	0.330	0.600	0.013	0.024		
c1	1.170	1.400	0.046	0.055		
D	8.509	9.450	0.335	0.372		
D1	6.900	-	0.272	-		
E	9.700	10.363	0.382	0.408		
E1	6.500	8.600	0.256	0.339		
е	2.5	540	0.1	00		
e1	5.0	080	0.200			
N	3		3	3		
L	13.000	14.000	0.512	0.551		
L1	-	4.800	-	0.189		
L2	-	1.727	1-1	0.068		

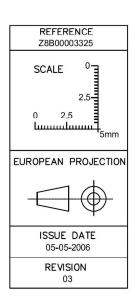


Figure 1 Outline PG-TO262-3, dimensions in mm/inches

OptiMOS[™]5 Power-Transistor, 150 V IPI076N15N5



Revision History

IPI076N15N5

Revision: 2016-03-03, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)			
2.0	2016-03-03	Release of final version			

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